STEREO IMPACT

PROBLEM REPORT PR-1015 SEP LVPS FM1 July 28,2004

PR Numbers: 1xxx=UCB, 2xxx=Caltech/JPL, 3xxx=UMd, 4xxx=GSFC/SEP, 5xxx=GSFC/Mag, 6xxx=CESR, 7xxx=Keil, 8xxx=ESTEC, 9xxx=MPAe					
Assembly: SEP LVPS FM1		SubAssembly: SEP Middle			
Component/Part Number: SEP Middle		Serial Number: FM1			
Originator: Selda Heavner		Organization: UC Berkeley			
Phone : 510 643-8640		Email: selda@ssl.berkeley.edu			
Failure Occurred During (Check one √)					
√ Functional test	☐ Qualification test	☐ S/C Integration	☐ Launch operations		
Environment when failure occurred:					
√ Ambient	☐ Vibration	□ Shock	□ Acoustic		
☐ Thermal	□ Vacuum	☐ Thermal-Vacuum	□ EMI/EMC		
Problem Description					
SEP LVPS FM1 was disassembled to troubleshoot the noise problem on 2.6V and 5.3V outputs. During troubleshooting, it was observed that Q22 and Q15 (FETs) drain waveforms were not the expected waveforms. The output voltages were still within the expected value. The output of U21 the triple 3-input NAND (54AC10) gate was always high. The SEPT-NS 2.6V was oscillating. The ripple was about 0.4V. The noise problem was intermittent. The tuning capacitor of LTC 1877 was not sufficient.					
Analyses Performed to Determine Cause					
Initially visual inspection was performed to see if there were any foreign objects on the pcb. The signals at the pins were checked using an oscilloscope. The resistance of each pin at 54AC10 to ground and the resistance between the pins were checked. The signal from the flip-flop U27 (54AC109) was absent.					

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- 1. The issues found during the troubleshooting for the noise problem (U27 and then U21) were most likely caused when the boards were disassembled. (Reference the corrective actions steps 1-4 below). This fix only applies to FM1.
- 2. The noise problem required a change in the tuning capacitor for the LTC1877. (Reference corrective action step 5.) This fix is required on both flight units.

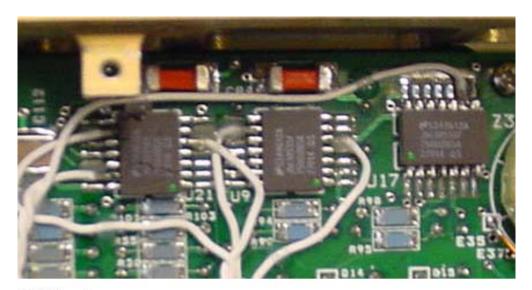
Corrective Action/ Resolution				
√ Rework (Step 1-4)	√ Repair (Step 5)	☐ Use As Is	☐ Scrap	

- 1- Removed and replaced the flip-flop U27
- 2- Removed and replaced the triple 3-input NAND gate U21.
- 3- Connected U27 pin 6 to U21pin 5; connect U27 pin 7 to U21 pin 9. (Note: they must be twisted together per rework document dated 4/02/04)
- 4- Staked the wires using Uralane 5753. (Added more staking to the wires to protect this connection)
- 5- Changed C32 to 390pF capacitor to eliminate the unstable output at 2.6V. The drawings were updated to reflect this change. (This fix applies to both flight units.)

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Date Action Taken:August 2, 2004 Reboth FM1 and FM2 were successful.	etest Results: Board level and box level tests on					
Corrective Action Required/Performed on other Units √ Serial Number(s):FM2*						
* Only item 5 in Corrective Actions section was closed on FM2 to eliminate the noise problem.						
Closure Approvals						
Subsystem Lead:	Date:					
IMPACT Project Manager:	Date					
IMPACT QA:	Date:					
NASA IMPACT Instrument Manager:	Date:					



U21 Repair



U27 Repair

